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Арр	lication No.	Applicant(s)
	9/832,844	YAMAZAKI, SHUNPEI
Al - 4! F All E !!! 4 -	miner	Art Unit
· Mi	n-Loan T. Tran	2826
The MAILING DATE of this communication appears of All claims being allowable, PROSECUTION ON THE MERITS IS (OR Finerewith (or previously mailed), a Notice of Allowance (PTOL-85) or of NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS of the Office or upon petition by the applicant. See 37 CFR 1.313 and I	REMAINS) CLOSED in ner appropriate commu S. This application is s	this application. If not included nication will be mailed in due course. THIS
1. X This communication is responsive to RCE and IDS filed on 09/2	<u>3/2005</u> .	
2. X The allowed claim(s) is/are 7.8.10-12.14-16.18.26.27.29-32.35.3	36,39-41 and 47-49.	
3. ☑ Acknowledgment is made of a claim for foreign priority under 3 a) ☑ All b) ☐ Some* c) ☐ None of the:		or (f).
1. Certified copies of the priority documents have been		
2. Certified copies of the priority documents have been		
3. Copies of the certified copies of the priority document	nts have been received	In this national stage application from the
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this noted below. Failure to timely comply will result in ABANDONMENT THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.		a reply complying with the requirements
i. A SUBSTITUTE OATH OR DECLARATION must be submitted. INFORMAL PATENT APPLICATION (PTO-152) which gives rea		
5. CORRECTED DRAWINGS ( as "replacement sheets") must be s	submitted.	
(a) ☐ including changes required by the Notice of Draftsperson's F	Patent Drawing Review	( PTO-948) attached
1) 🗌 hereto or 2) 🔲 to Paper No./Mail Date		
(b) ☐ including changes required by the attached Examiner's Ame Paper No./Mail Date	endment / Comment or	in the Office action of
Identifying indicia such as the application number (see 37 CFR 1.84(c)) each sheet. Replacement sheet(s) should be labeled as such in the hea		
<ol> <li>DEPOSIT OF and/or INFORMATION about the deposit of attached Examiner's comment regarding REQUIREMENT FOR</li> </ol>		
Attachment(s)  I. Notice of References Cited (PTO-892)	5. ☐ Notice of Inf	ormal Patent Application (PTO-152)
2. ☐ Notice of Praftperson's Patent Drawing Review (PTO-948)		Immary (PTO-413),
B. ⊠ Information Disclosure Statements (PTO-1449 or PTO/SB/08),	Paper No./	Mail Date Amendment/Comment
Paper No./Mail Date 9/23/05		01-1
I. ☐ Examiner's Comment Regarding Requirement for Deposit of Biological Material	გ. ⊠ Examiner's :	Statement of Reasons for Allowance
	9. 🗌 Other	· dombton 5
		· -
		Minhloan 7ran Primary Examiner Art Unit 2826

U.S. Patent and Trademark Office PTOL-37 (Rev. 7-05) Application/Control Number: 09/832,844

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# **DETAILED ACTION**

## Continued Examination Under 37 CFR 1.114

1. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after allowance or after an Office action under *Ex Parte Quayle*, 25 USPQ 74, 453 O.G. 213 (Comm'r Pat. 1935). Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, prosecution in this application has been reopened pursuant to 37 CFR 1.114. Applicant's submission filed on 09/23/2005 has been entered.

## Information Disclosure Statement

2. The information disclosure statement filed 09/23/2005 has been considered.

## **REASONS FOR ALLOWANCE**

3. The following is an examiner's statement of reasons for allowance:

Claims 7, 8, 10-12, 14-16, 18, 26, 27, 29-32, 35, 36, 39-41, 47-49 are allowable over the references of record because none of these references disclose or can be combined to yield the claimed invention such as a display device comprising a plurality of switching elements formed on a substrate having an insulating surface wherein each of the switching elements comprising at least one first thin film transistor; an interlayer insulating film comprising resin formed over the plurality of switching elements wherein the pixel electrodes are provided over the interlayer insulating film; a driver circuit

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formed over the substrate and comprising a plurality of second thin film transistors; wherein all of the first thin film transistors and the second thin film transistors are NTFTs or PTFTs; or each of the first and second thin film transistors comprising a semiconductor film contains oxygen at a concentration not higher than 7x10<sup>19</sup> atoms/cm<sup>3</sup> and wherein all of the first thin film transistors and the second thin film transistors are NTFTs or PTFTs.

## Conclusion

4. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Minh-Loan T. Tran whose telephone number is (571) 272-1922. The examiner can normally be reached on Monday-Friday 9:00 AM-5:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan J. Flynn can be reached on (571) 272-1915. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

MIt 09/05 Minh-Loan T. Tran Primary Examiner Art Unit 2826